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AP3 Rec'd PCT/PTO 23 JUN 2016

Docket No.: 4590-549 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Louis PENAVAIRE et al.

Confirmation No.

U.S. Patent Application No. not yet assigned

Filed: herewith

For: REMOTELY TESTABLE TEMPERATURE SENSOR

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Please note this is a PCT application in the entry of the National Phase in the U.S. and copies of the references cited were transmitted by WIPO and are believed to be in the file of the above-identified application and readily available to the Examiner. Therefore it is believed that Applicants have met all requirements regarding duty of disclosure under 37 CFR 1.56. A copy of the foreign search report is attached for the Examiner's information. Acknowledgement and consideration of these documents are respectfully requested.

Respectfully submitted,

LOWE HAUPTMAN & BERNER, LLP

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Date: June 23, 2006

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ATTY. DOCKET NO. U.S. APPLICATION NO. 4590-549 Not yet assigned INFORMATION DISCLOSURE APPLICANT CITATION IN AN Louis PENAVAIRE et al. **APPLICATION** FILING DATE **GROUP** herewith (PTO-1449) U.S. PATENT DOGUMENTS EXAMINER'S FILING CLASS **SUBCLASS** INITIALS PATENT NO. DATE NAME DATE 2002-06-27 Kadota Michio et al 2002/079989 A1 1 1 2 1 .11 1 FOREIGN PATENT DOCUMENTS **EXAMINER'S** PATENT NO. DATE COUNTRY CLASS **SUBCLASS** INITIALS 1 324 489 A 2003-07-02 OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) Buff W et al: "Universal Pressure and Temperature Saw Sensor for Wireless applications" Proceeding of the 1997, IEEE Ultrasonic Symposium, Ontario, Canada October 5-8, 1997 IEEE Ultrasonic Symposium. Ontario Canada Oct. 5-8 1997 IEEE Ultrasonic Symposium Proceedings New York, NY: IEEE, US October 5, 1997 Boron on **EXAMINER** DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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